RELIABILITY TEST RESULT

Product name : S-25C320A0I-J8TxU3 Package type : 8-Pin SOP(JEDEC)

No.	Test item	Test Condition	Test Time	r/n	Criterion
1	High-temperature operation	Ta=125 °C, V=Vopr max.	1000 h	0/22	Satisfies the product standard
2	Temperature humidity bias #1	Ta=85 °C, RH=85 %, V=Vopr max.	1000 h	0/22	Satisfies the product standard
3	Pressure cooker bias ^{#1}	Ta=125 °C, RH=85 %, P=2×10 ⁵ Pa V = Vopr max.	100 h	0/22	Satisfies the product standard
4	Storage in high temperature	Ta=150 °C	1000 h	0/22	Satisfies the product standard
5	Storage in low temperature	Ta=–65 °C	1000 h	0/22	Satisfies the product standard
6	Write/Erase Cycle	Ta=25 °C, V=Vopr max.	1×10^{6} cycles	0/22	Satisfies the product standard
7	Temperature Cycle (Gas phase) #1	Ta=150 °C ⇔ –65 °C 15 minutes for each	500 cycles	0/22	Satisfies the product standard
8	Resistance to soldering heat-1 (reflow soldering) #2	T=260 °C ,10 s	3 times	0/22	Satisfies the product standard No abnormality by appearances
9	Resistance to soldering heat-2 (Soldering Iron) ^{#2}	T=380 °C , 5 s (Soldering iron tip temperature) Object : terminal parts	2 times	0/22	Satisfies the product standard No abnormality by appearances
10	Resistance to soldering heat - 3 (Flow soldering) ^{#2}	T=260 °C ,10 s	1 time	0/22	Satisfies the product standard No abnormality by appearances
11	Solderability ^{#3}	T=245 °C Solder material:Sn-3.0Ag-0.5Cu	5 s	0/11	Zero cross time should be less than 3 seconds. Solder should be applied at 95% or more of solderability judgment area.
12	Whisker - 1 (Temperature / Humidity Storage)	Ta=30 °C, RH=60%	4000 h	0/6	Whisker should be less than 40µm
13	Whisker - 2 (Temperature Cycling)	Ta=85 °C ⇔ –40 °C	1500 cycles	0/6	Whisker should be less than 45µm
14	Whisker - 3 (High Temperature / Humidity Storage)	Ta=55 °C, RH=85 %	4000 h	0/6	Whisker should be less than $40\mu m$
15	Solder Joint Reliability (shear test) ^{#3}	Ta=125 °C ⇔ –40 °C Solder material ∶ Sn-3.0Ag-0.5Cu	2000 cycles	0/22	After temperature cycle test, keep strength for shear stress more than the 50 % of initial mean value.
16	Terminal Strength (Pull test)	Pull force : 5.0 N	30 s	0/11	Terminal is not taken off
17	Terminal Strength (Bending test)	Load : 2.5 N, 45 degree Bend a lead	2 times	0/11	Terminal is not taken off
18	ESD - 1 (Human Body Model)	V=±2000 V, C=100 pF, R=1.5 k Ω Ground : V _{CC} / GND	5 pulses	0/5	Satisfies the product standard
19	ESD - 2 (Charged Device Model)	V=±500V charged, discharged	1 pulse	0/5	Satisfies the product standard
20	Latch up (Pulsed current injection test)	±100 mA, V =Vopr max.	1 pulse	0/5	No latch up

Remark : Vopr max. =Maximum operation voltage

#1,2,3 : Each test designated # is performed after Pre-Treatment finished. Pre-Treatment consists of High Temperature Storage ,Temperature Humidity Storage and Soldering Heat. (See the table below.)

	Pre Treatment (#1)					
High Temp. Storage	Temperature Humidity Storage	Soldering Heat				
Ta=125 °C t=24 h	Ta=85 °C RH=85 % t=168 h	Reflow 3 times T=260 °C t=10 s				

	Pre Treatment (#2)				
High Temp. Storage	Temperature Humidity Storage	Soldering Heat			
Ta=125 °C t=24 h	Ta=85 °C RH=85 % t=168 h	_			

	Pre Treatment (#3)				
High Temp. Storage	Temperature Humidity Storage	Soldering Heat			
_	Ta=105 °C RH=100 % t=8 h	_			